#### We Claim:

# 1. A method, comprising:

applying photo-thermal energy to a layer of first material disposed on a layer of second material to diffuse a portion of the first material into the second material.

### 2. The method of claim 1, wherein:

the photo-thermal energy is provided by one of a YAG laser, a CO<sub>2</sub> laser, and an infrared laser.

### 3. The method of claim 1 wherein:

the second material includes metal; and

the photo-thermal energy penetrates at least into the first layer such that the diffusing forms an electrically conductive trace.

### 4. The method of claim 3, wherein:

the first material includes tin, the second material includes copper, and the metal trace includes a copper tin alloy.

### 5. The method of claim 3, wherein:

the photo-thermal energy includes a laser beam having a width between about 2 mils and about 8 mils.

- 6. The method of claim 3, further comprising: removing non-diffused portions of the first layer; and removing non-diffused portions of the second layer.
- 7. The method of claim 6, wherein:
  the diffusing forms a metal trace that is between about 20 % and about 30% larger prior
  to said removing the non-diffused portions of the first and second layers.
- 8. The method of claim 6, wherein:
  the substrate is a package substrate having a core with an initial via therethrough, the
  core to support the metal trace, the method further comprising

filling the via with a polymer;

forming a new via through the polymer leaving the new via lined with the polymer; and

depositing interconnect material in the new via.

- 9. The method of claim 8, further comprising: depositing inter-layer dielectric material to isolate the metal trace and form a metal trace layer.
- 10. The method of claim 9, further comprising:

  planarizing the metal trace layer to ensure that a surface of the metal trace is exposed;

  and

  electronically coupling the surface to a die to the package substrate to form a

  semiconductor package.

## 11. A method comprising:

forming a metal layer on a core;

placing a diffusion layer on the metal layer; and

applying photo-thermal energy to the diffusion layer to diffuse a portion of the diffusion layer into the metal layer.

## 12. The method of claim 11, wherein:

the diffusion layer includes a conversion coating material to protect the metal layer from oxidation.

13. The method of claim 11, further comprising:

removing undiffused portions of the diffusion layer.

14. The method of claim 13, wherein:

said removing includes removing with chemical mechanical processing.

15. The method of claim 11, further comprising:

removing undiffused portions of the metal layer.

16. The method of claim 15, wherein:

said removing includes removing with chemical mechanical processing.

### 17. An apparatus, comprising:

an electrically conductive trace on a substrate, the electrically conductive trace including first and second materials, the electrically conductive trace formed by

applying photo-thermal energy to a selected area of a first layer of the first material disposed on a second layer of the second material; and

diffusing a portion of the first material into a portion of the second material responsive to said applying.

# 18. The apparatus of claim 17, wherein:

the substrate is part of one of a semiconductor package, a printed circuit board, and a die.

### 19. The apparatus of claim 17, wherein:

the second layer includes metal.

### 20. The apparatus 17, wherein:

the electrically conductive trace includes a copper tin alloy.

## 21. The apparatus of claim 17, wherein:

the electrically conductive trace is between about 10 microns and about 20 microns in thickness and between about 27 microns and about 35 microns in width.

### 22. The apparatus of claim 17, further comprising:

an inter-layer dielectric material electrically isolating the electrically conductive trace.

23. The apparatus of claim 17, wherein: the second material includes copper.

- 24. The apparatus of claim 17, wherein: the first material includes tin.
- 25. The apparatus of claim 17, wherein: the first material includes an organic material.
- 26. The apparatus of claim 17, wherein: the first material includes a conversion coating material.